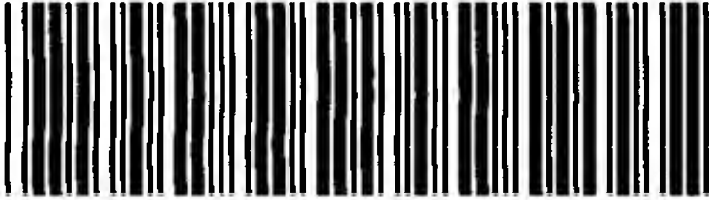


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/701,049	BEDINGFIELD ET AL.	
	Examiner	Art Unit	
	Quynh H. Nguyen	2614	

SEARCHED			
Class	Subclass	Date	Examiner
379	219 220.01 221.01 265.02 265.09	7/17/07	QN
above	updated	7/17/07	QN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
379	219 220.01 221.01 265.02 265.09	7/17/07	QN
Interference search history printout		7/15/07	QN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Searched: East, USPGPub, USPAT, EPO, JPO	7/17/07	QN
Inventor search in PALM database	7/17/07	QN